LT6820 Substage

Our range of stages are suited for orthogonal positioning solutions in atmosphere, SEM/FIB, UHV and at low temperatures.

The LT6820 is primarily used in SEM/FIB to enhance the accuracy and functionality of the standard microscope stage. It is an economical and technically superior alternative to laser interferometer stages.

It is designed specifically for lithography, cell counting and failure analysis applications and is fitted with positional encoders allowing 100 nm repeatability on the X and Y axes.



APPLICATIONS

Substage for SEM & FIB

- Cell counting
- eBeam lithography
- Tensile measurement
- Particle counting
- Metrology
- Forensic analysis

CUSTOMIZATION

Two or three linear axes Positional encoder on Z axis Ultra high vacuum compatible Non-magnetic material





LT6820 Substage

More compact and more flexible

- Small and practical
- Plug-and-play system with modular design
- Interfacing solutions for most SEM/FIB instruments (including load lock)
- Fast setup and removal

Clearer and simpler

- Result-oriented operation which leads to increased throughput
- Intuitive control interfaces, user-friendly software and API support
- User-friendly and easy to learn
- Compact, stand-alone electronics
- Pioneering cabling technology with compact vacuum feedthrough

More robust and more stable

- Compact construction delivers higher resonance frequencies
- Excellent stability
- Virtually insusceptible to vibrations
- Reliable operation (one year endurance test)
- Fast pre-positioning by hand
- Functions in extreme working environments

Faster and more precise

- No backlash or reversal play
- Sub-nanometer resolution (< 0.5 nm)
- Coarse and fine displacement in one drive
- High operating velocity (up to 2 mm/sec)
- Low drift (1 nm/min)
- Smooth motion

Technical specifications

- Length 68 mm
- Width 68 mm
- Height XY 26 mm
 Height XYZ 50 mm + 15 mm travel
- Weight XY 200 g
- Weight XYZ 270 g • Travel XY 20 mm
- Travel Z 15 mm Speed up to 2 mm/s
- Resolution < 0.02 nm
- Encoder repeatability 100 nm *
- Angular deviation (undirectional) < 10 µrad

X,Y = HORIZONTAL

7 = VERTICAL

- Load 500 g
- Lift 200 g
- Temperature range 273 K to 353 K UHV version 273 K to 393 K
- Lowest pressure 10⁻⁷ mbar
 UHV version 2 × 10⁻¹⁰ mbar
- Substage mounting 4×3.2 mm holes
- Sample mounting 4 × M3 holes
- Material Stainless steel

* Repeatability depends on the working distance from the encoder due to the angular deviation of the substage

> Contact us at info@kleindiek.com or find your local agent at www.kleindiek.com

